Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/677,305	YOON ET AL.	
Examiner	**Art Unit**	
B. Clayton McCraw	3744	

SEARCHED			
Class	Subclass	Date	Examiner
62	157,231,175	11/9/2005	BCM
236	51	11/9/2005	BCM
700	295,276	11/9/2005	BCM
236	51	6/26/2006	BCM

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
Consulted with Primary Examiner, Marc Norman	11/9/2005	BCM
Conducted Inventor Name Search	11/9/2005	BCM
Consulted with Primary Examiner, Melba Bumgarner	11/28/2005	BCM
EAST Search Notes Attached	11/28/2005	BCM
Consulted with Primary Examiner, Marc Norman	6/27/2006	BCM
EAST Search Notes Attached	6/27/2006	BCM